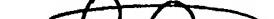


Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10015322	DANSIE ET AL.
	Examiner	Art Unit
	Nano, Sargon N	2157

Nano, Sargon N (Assistant Examiner)	7/20/2007 (Date)	 ARIO ETIENNE SUPERVISORY PATENT EXAMINER	Total Claims Allowed: 10
(Legal Instruments Examiner)	(Date)	PRIMARY EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner)	O.G. Print Claim(s) 8
		(Date) 7/23/07	O.G. Print Figure 1